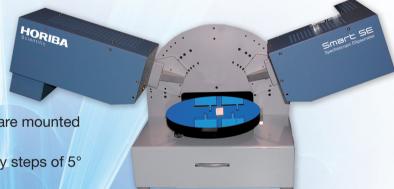


Smart SE

Spectroscopic Ellipsometer for Thin Film Analysis

The Smart SE is an innovative spectroscopic ellipsometer for easy, fast and accurate characterization of thin films, from single to multi-layers.

The CCD detector of the Smart SE acquires accurate ellipsometric data from 450 nm to 1000 nm in less than 1 second



Smart SE

Visualization of the spot on the sample

with the MyAutoView vision system

⇒ Flexible

The optical heads of the Smart S∈ are mounted on a compact manual goniometer that allows data acquisition from 45° to 90° by steps of 5°

▽ Versatile

The Smart SE can be upgraded with:

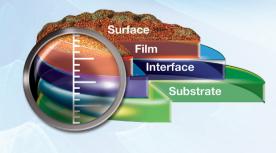
- → 200 mm or 300 mm mapping stage for uniformity measurements
- Automated variable angle of incidence for complex analysis
- In-situ configuration for real-time process monitoring

□ Unique Capabilities

- → MyAutoView vision system for accurate positioning of the spot on any opaque or transparent substrates
- Seven automated micro spot sizes for measurements of patterned samples
- Full Mueller matrix measurement capability to study anisotropic and depolarizing samples

Thin Film Applications

- Film thickness from a few Å to 15 μm
- → Optical constants (n, k)
- Optical bang gap
- Gradient, anisotropy and depolarization







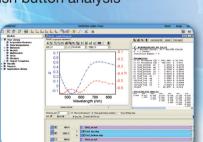
The Smart SE integrates two level of software to fulfill both routine analysis with predefined recipes and advanced analysis with state-of-the-art ellipsometric algorithm:

Auto Soft Routine Mode

- Auto Soft is an intuitive software that allows inexperienced users to acquire and analyze data in one push of a button
- Four interfaces to control the system, run an experiment, manage the data and perform maintenance test
- Predefined recipes are listed by applications and materials
- Fitting and tabulated data are presented on the same screen for fast reading (goodness of fit, thickness, optical constants, band gap, composition)

DeltaPsi2 Advanced Mode

- Over the last two decades, HORIBA Jobin Yvon DeltaPsi2 Ellipsometric software has acquired a brand equity and is recognized as one of the most advanced and powerful commercial ellipsometric software
- Build your model to characterize anisotropic, depolarizing and graded samples
- Customize existing dispersion functions with our unique User Defined Formula and fit new material properties
- Export Recipes from DeltaPsi2 to AutoSoft for push button analysis



Specifications

Standard configuration

→ Spectral range: 450 nm to 1000 nm Spectral resolution: Better than 3 nm

→ Light source: Combined Halogen and Blue LED

Measurement time: < 1 sec. to 10 sec.

 $75 \mu m \times 150 \mu m$, $100 \mu m \times 250 \mu m$, → Beam size:

100 μm x 500 μm, 150 μm x 150 μm,

250 μm x 250 μm, 250 μm x 500 μm,

500 μm x 500 μm

45° to 90° by step of 5° Angle of incidence:

Sample size: Up to 200 mm

Sample alignment: Manual 17 mm height adjustment and tilt

Dimensions: 100 cm x 46 cm x 23 cm (W x H x D)

Performance

Straight-through air accuracy:

→ Thickness accuracy on 1000 Å oxide: 04%

→ Thickness repeatability on 1000 Å oxide: ±0.02%

Options

- → Automated angle of incidence from 45° to 90° by step of 0.01°
- → Motorized stage for 200 mm and 300 mm sample sizes
- In-situ adjustable flanges for mounting on process chamber
- Heating and cooling stages
- Liquid and electrochemical cells
- Cross hair auto-collimation system

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 $\Psi = 45^{\circ} \pm 0.05^{\circ} \quad \Delta = 0^{\circ} \pm 0.2^{\circ}$

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